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# Tuning the Oxygen Content of Reduced Graphene Oxide and Effects on Its Properties

Wei Liu and Giorgio Speranza\*

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**ABSTRACT:** The need to recover the graphene properties in terms of electrical and thermal conductivity calls for the application of reduction processes leading to the removal of oxygen atoms from the graphene oxide sheet surface. The recombination of carbon–carbon double bonds causes a partial recovery of the original graphene properties mainly limited by the presence of residual oxygen atoms and lattice defects. However, the loss of polar oxygen-based functional groups renders the material dispersibility rather complicated. In addition, oxygen-containing functional groups are reaction sites useful to further bind active molecules to engineer the reduced graphene sheets. For these reasons, a variety of chemical processes are described in the literature to reduce the graphene oxide. However, it is greatly important to select a chemical process enabling a thin modulation of the residual oxygen content thus tuning the properties of the final product. In this work, we will present a chemicalprocessing technique based on the hydroiodic acid to carefully control the



degree of residual oxidation. Graphene oxides were reduced using hydroiodic acid with concentrations from 0.06 to 0.95 mol L<sup>-1</sup>. Their properties were characterized in detail and tested, and the results showed that their oxygen content was finely tuned from 33.6 to 10.7 atom %. This allows carefully tailoring the material properties with respect to the desired application, which is exemplified by the variation of the bulk resistance from 92  $\Omega$  to 14.8 M $\Omega$  of the film from the obtained rGO.

# **1. INTRODUCTION**

Carbon atoms of graphene are densely packed into a honeycomb lattice structure with sp<sup>2</sup> bonding hybridization. The resulting two-dimensional atomic monolayer consequently has outstanding electron conductivity, excellent mechanical strength, superior thermal conductivity, and a high surface area.<sup>1</sup> These unique properties render graphene a promising material for a variety of applications from electronics to energy conversion and storage, sensing, medicine, and catalysis.<sup>2</sup> However, one of the barriers that obstructs its wide replacement of conventional materials in these applications is scalability and cost of graphene production. Various methods have been developed for graphene synthesis and can be generally categorized into bottom-up and top-down approaches. Chemical vapor deposition (CVD) is a typical bottom-up approach, which builds a graphene sheet through thermal decomposition of hydrocarbon molecules on a catalytic substrate surface.<sup>7</sup> A large-area and high-quality graphene sheet was prepared by CVD, but this process suffers greatly from a low production rate, high cost, and sophisticated instrumentation. The alternative top-down approach produces separated graphene sheets by exfoliation of inexpensive bulk graphite. The exfoliation techniques include micromechanical cleavage, solution exfoliation, chemical exfoliation, and electrochemical exfoliation, among which chemical exfoliation could

be a promising route to produce large amounts of graphene at low  ${\rm cost.}^8$ 

In the process of chemical exfoliation of graphite, bulk graphite is first chemically oxidized into graphite oxide using strong oxidation agents.<sup>9</sup> During the oxidation reaction, various functional groups, such as hydroxyl and epoxide randomly distributed on the basal surface and carboxylic acid at edges, are introduced,<sup>10</sup> which intercalate with water molecules to increase the interlayer spacing. The enlarged layer distance makes it possible to delaminate graphite oxide into graphene oxide (GO) under ultrasonication.<sup>11</sup> The presence of oxygen functionalization in GO partially breaks sp<sup>2</sup>–sp<sup>2</sup> bonds into sp<sup>3</sup>–sp<sup>3</sup> bonds, which makes GO a good insulator.<sup>12</sup> A subsequent GO transformation into reduced GO (rGO) can be performed to restore the  $\pi$ -conjugated structure and conductivity resembling graphene.

The chemical exfoliation approach not only provides an efficient pathway to produce a graphene-like structure with

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superior properties, but also provides this kind of material great tunability for different applications. With a low oxygen content, as mentioned above, rGO recovers to some extent graphene's properties and becomes a good electrical and thermal conductor, although there will be some differences because of incomplete reduction and defect formation.<sup>13</sup> In contrast, with high oxygen contents, polar functionalities on rGO make it more hydrophilic to be dispersible in polar solvents, especially in aqueous solution. More importantly, oxygencontaining functional groups provide reaction sites to produce functionalized GO. For example, GO/rGO composites containing metal nanoparticles,<sup>14–16</sup> oxides/hydroxides,<sup>17–20</sup> organic molecules,<sup>21,22</sup> and doped heteroatoms<sup>23</sup> have been reported to be successfully synthesized. Therefore, fine tuning the oxygen contents is important for the performance optimization of rGO.

Many reducing agents, for example, H<sub>2</sub>S,<sup>24</sup> hydrazine,<sup>25</sup> NaBH4,<sup>26</sup> hydrohalic acid,<sup>27</sup> metal iodide,<sup>28</sup> ascorbic acid,<sup>29</sup> amino acids,<sup>30</sup> etc. have been investigated for GO reduction to prepare rGO. Depending on their reducing potential and reaction mechanism, the properties of final rGO products from different reductants showed significantly different properties. Their oxygen content in terms of the C/O ratio varied from 30 to 2.2, and conductivities changed from  $3.2 \times 10^{-5}$  to 55,088 S m<sup>-1</sup>.<sup>28,31</sup> Hydrazine and its derivatives are well-known reagents for the GO reduction. Stankovich et al. reported that the C/O atom ratio increased from 2.7 to 10.3 after reduction with hydrazine hydrate.<sup>32</sup> However, in addition to the decrease of the oxygen level, reduction with hydrazine also left nitrogen impurities,<sup>32,33</sup> which is supposed to cause lower conductivity than pristine graphene.<sup>34</sup> NaBH<sub>4</sub> is also effective as a reductant for GO and can overcome the nitrogen contamination problem of hydrazine. One problem of NaBH4 reduction is its hydrolysis, which can reduce its reduction efficiency. A C/O ratio of about 6.8 of rGO reduced by NaBH<sub>4</sub> was achieved in 2.1 h reduction treatment.<sup>35</sup> Recently, green reductants have attracted much attention for GO reduction. Ascorbic acid is one of the most studied green reductants, which is nontoxic to environment and microorganisms, and the obtained rGO can be used for biomedical applications. However, its reduction strength is not comparable to hydrazine. The obtained rGO products have a C/O range of  $2.7-6.^{36,37}$  Up to now, the most effective reductants for GO reduction have been hydroiodic acid or metal iodide. The rGO samples reduced by 55% hydroiodic acid (HI) at 100 °C for 1 h reached a C/O ratio higher than 12 and a high conductivity of 29,800 S m<sup>-1</sup>. The rGO reduced by the FeI<sub>2</sub> acid solution at 95 °C for 6 h also showed a conductivity as high as 55,088 S m<sup>-1</sup>. The high conductivities of these two samples have been attributed to the nucleophilic substitution reaction of oxygen-containing functional groups by I<sup>-</sup>, the reaction promotion by a high concentration of H<sup>+</sup>, and easy elimination of most of the iodine atoms.<sup>28,38</sup>

Therefore, in consideration of the importance of tuning of the oxygen content and powerful restoration of properties after hydriodic (HI) reduction, we herein report in detail the tuning of the oxygen content of rGO by controlling the HI solution concentration during the chemical reduction in aqueous solution. The evolution of the structure and properties of rGO along with the degree of reduction was investigated using various techniques. This study provided an easy and efficient way to control the oxygen content of rGO, which could find various applications depending on its oxygen content.

#### 2. RESULTS AND DISCUSSION

**2.1. Successful Reduction of GO.** We first performed XPS measurements to check the success of GO reduction to rGO by the HI aqueous solution. A survey scan from 0 to 1200 eV binding energy was first carried out for the GO and rGO samples. The spectra are shown in Figure 1. For comparison



Figure 1. Wide survey XPS spectra of GO and rGO reduced with different HI concentrations.

purpose, all the wide survey spectra were normalized to C 1s peaks. The main peaks at about 284 and 531 eV can be attributed to C 1s and O 1s, respectively.<sup>39</sup> In the GO spectrum, the O 1s peak is dominant over C 1s, which reveals that GO is rich in oxygen functional groups before reduction. Compared with GO, there is a significant decrease in the O 1s peak intensity in rGO samples along with the increase of the HI solution concentration. This is a direct indication of successful removal of oxygen atoms from GO and a good control of the reduction degree of rGO. For rGO, two weak peaks from iodine were also detected at 619.1 eV (I3d 5/2) and 630.9 eV (I3d 3/2),<sup>40</sup> which means that a small amount of I atoms remains after reduction, especially for samples reduced by high HI concentrations.

The thermogravimetric analysis-differential scanning calorimetry (TGA-DSC) technique is another powerful technique to prove the accomplishment of a controlled reduction of GO to rGO. During the TGA-DSC measurement, a thermal reduction process of GO/rGO samples occurred by removing the oxygen functional group in the form of CO or CO<sub>2</sub> gases. Therefore, the weight loss during this measurement is dependent on the oxygen content of GO/rGO. As shown in Figure 2, GO obviously showed the highest weight loss of 51.2 wt % when the measurement temperature reached 800 °C. The rGO samples, as expected, showed much lower weight loss because of less oxygen functional groups after reduction. Their values decreased in the reversed order of the HI concentration gradually from 38.3 to 29.8, 23.4, 19.7, and 16.1 wt %, respectively.

The weight losses of GO and rGO proceeded in three steps. Minor weight loss (less than 5 wt %) below 150 °C is supposed to be because of the escape of adsorbed water molecules. Main weight losses of GO and rGO occurred in the temperature range from 150 to 400 °C resulting from the thermal decomposition of oxygen-containing functional groups into H<sub>2</sub>O, CO, and CO<sub>2</sub> gases. The slow weight loss after 400 °C is caused by the elimination of more stable functional groups.<sup>41-43</sup> Accompanied by the removal of oxygen-containing functional groups, an exothermic peak at 100–



Figure 2. TGA curves of GO and rGO reduced with different HI concentrations.

250 °C was detected on DSC curves as shown in Figure 3. The exothermic nature of this reaction has been widely reported



Figure 3. DSC curves of GO and rGO reduced with different HI concentrations.

previously<sup>44</sup> and explained by the transformations of epoxide groups and accelerated by the presence of OH groups. Therefore, it is obvious that the TGA–DSC results are highly in agreement with the XPS results (wide spectra in Figure 1) showing the success of controllable reduction of GO by varying the HI solution concentration.

The UV-vis spectra in Figure 4 show that with the increase of the HI reducing agent concentration, a red-shift of the absorption peak occurs. For the GO sample, the absorption occurs at 238 nm as found by other authors 45-47 resulting from the  $\pi - \pi^*$  transition of aromatic C–C bonds. The GO sample also shows a visible feature at  $\sim$ 303 nm, which is commonly attributed to  $n-\pi^*$  due to both C=O bonds<sup>47</sup> and to optical transitions between  $\pi$  and  $\pi^*$  states in the finite-sized molecular sp<sup>2</sup> domains and the nanometer-size sp<sup>2</sup> clusters.<sup>48,49</sup> Upon reduction, the absorption band at 238 nm red-shifts and the feature at 303 nm disappears. In addition, the shift of the absorption band increases with increasing degree of the GO reduction. The shift toward the NIR is caused by the conversion of sp<sup>3</sup> oxygen-coordinated carbon atoms to sp<sup>2</sup> with the carbon oxygen bond breakage and recombination in C=C.<sup>50</sup> Then, also the sequence of the UV-vis spectra shows a substantial agreement with the previous experiments where the loss of oxygen atoms induced by HI leads to a reduction of the bandgap (graphitization) with a parallel reduction of the absorption band frequency and disappearance of the oxygenrelated absorption features.



**Figure 4.** UV-vis spectra of GO and rGO reduced with different HI concentrations.

**2.2. Effects of Oxygen Contents on Surface and Structural Properties.** To determine the oxygen contents and surface functional groups of GO and rGO samples, high-resolution XPS spectra of C 1s and O 1s were acquired. Figure S1 reports the trend of the O 1s and C 1s line shapes as a function of the HI concentration. Figure S1A shows that increasing the HI concentration induces a lowering of the O 1s intensity. In agreement with this finding, the intensity of the oxidized carbon components also decreases in the BE range 286–290 eV as summarized in Figure S1C. For the sake of clarity, to better appreciate the effect of the increasing HI concentration on the reduction process, the C 1s core lines were normalized to a common height. An example of the O 1s and C 1s peak fitting is reported in Figure S1B and S1D.

The C 1s spectrum of GO can be fitted using six peaks corresponding to carbon atoms in different chemical environments. The peak at 284.4 eV describes the sp<sup>2</sup>-hybridized C atoms arranged on the corner of a hexagon as in graphite. The peak at ~285.4 eV corresponds to sp<sup>3</sup>-hybridized carbon atoms,<sup>51</sup> which likely derives from unsaturated carbon atoms reacting with hydrogen during the oxidation process as shown using theoretical models.<sup>10</sup> The peak at  $\sim$ 286.4 is assigned to epoxy and hydroxyl functional groups. The peak at  $\sim$ 287 eV is attributed to the carbonyl group while a slightly higher binding energy describes the O-C-O bond. The highest BE around 289.5 eV describes the carboxyl acidic component.<sup>35,52-54</sup> The results of the spectral peak fitting are summarized in Table 1. In the spectrum of GO, the more intense peak is attributed to C-OH bonds. Acid treatment is needed to exfoliate graphite leading to graphene sheet formation, responsible for the oxidation of carbon atoms. There are different models describing the oxidation of the resulting graphene sheets. The experimental evidence from different techniques leads to a collective picture where the dominant structural features present on the surface of GO are attributed to tertiary alcohols and ethers, most likely 1,2-ethers (i.e., epoxides)<sup>10</sup> as confirmed by the XPS spectrum of C 1s.

After reduction, the C 1s spectra of the rGO samples can be described by the same number of peaks, but their intensity changes significantly. The decreasing concentrations of oxygen calculated from the XPS spectra are plotted against the HI concentration in Figure 5. As can be observed, the main changes in the O 1s and C 1s core lines displayed in Figure

	O 1s conc. (%) C-OH			C 1s conc. (%)					
	C=0	C-O-C	H <sub>2</sub> O	C=C	C sp <sup>3</sup>	C-O-C	С=О	0-C-0	C-(C=O)
GO	7.78	24.7	1.11	30.01	0	22.88	6.9	4.17	1.37
rGO 0.06	3.5	18.36	1.02	48.46	7.01	16.68	3.12	1.53	0.32
rGO 0.12	1.62	14.9	2.59	55.11	7.14	14.19	3.51	0.95	0
rGO 0.24	2.55	8.35	0.46	74.44	6.05	4.73	2.47	0.96	0
rGO 0.47	3.24	6.91	0.32	76.47	6.02	4.55	1.62	0.87	0
rGO 0.95	3.29	7.17	0.2	76.53	6.97	4.43	0.78	0.63	0

Table 1. Bond concentrations as measured by XPS



Figure 5. Curve of the oxygen content in rGO vs HI concentration for reduction.

S1A and S1C are attributed to a steep decrease of the oxygen concentration with increasing molar concentration of HI acid in the reducing process. The efficiency of the acid treatment drops at HI concentrations ~0.2 mM letting the oxygen concentration almost constant at a value of 10%. There are several reduction methods of the GO (see e.g., the review<sup>31</sup>), they can be grouped into two categories: the first group is formed by reducing agents traditionally applied in synthetic chemistry with reaction pathways toward specific oxygen functional groups (i.e., metal hydrides are reactive toward carbonyl functional groups). To the second category belong reducing agents, which do not display any definite modes of reaction leading to nonspecific oxygen moieties.

Hydrohalic acids such as HI, HBr, and HCl are often utilized for electrophilic addition and nucleophilic substitution reactions. The halides are nucleophilic in nature, with increasing nucleophilicity from Cl<sup>-</sup> < Br<sup>-</sup> < I<sup>-</sup>. In particular, important property of the hydrohalic acids is their capability of opening epoxides.<sup>31</sup> These properties render the hydrohalic acids superior candidates for removing hydroxyl and epoxide groups which, as already observed, constitute the main part of oxygen functionalities on GO. According to the suggested reaction mechanism by Moon et al., The reduction process includes iodination of alcohols, cleavage of ether and iodination, reduction of aromatic iodides, and partial reduction of the carbonyl group.<sup>27</sup> The reaction scheme is summarized in Figure 6.

For instance, we observe that in our GO samples, the abundance of epoxy and hydroxyl functional groups is approximately 23%, while the concentration of all the



**Figure 6.** Suggested reaction mechanism of oxygen containing groups with HI. Reproduced from ref 31 with permission from The Royal Society of Chemistry.

remaining carbon-oxidized components amounts to  $\sim$ 12.5%. As a matter of fact, this well compares with the abundance of oxygen after HI reduction demonstrating the halide acid efficiency in removing the epoxy and hydroxyl functional groups.

Figure 7A displays the evolution of the normalized Raman spectra upon changing the concentration of the HI acid. In the Raman spectra, the 2D features at about 2700 cm<sup>-1</sup> are hardly visible at all the HI concentrations. For each HI concentration, the Raman spectra are dominated by the D band at ~1330 cm<sup>-1</sup>. Figure 7B represents an expanded view of the D and G bands in the range 1100–1800 cm<sup>-1</sup>, which are normalized to a common height to better appreciate the line shape changes. It can be seen that increasing the HI concentration in the reducing process, the intensity of the peak at ~1600 cm<sup>-1</sup> decreases. In addition, there are opposite trends for the widths of the two main peaks, the first decreases with increasing HI concentration while the second at a higher Raman shift increases revealing the coexistence of the two contributions deriving from the G and D' features.

The Raman peaks were fitted following the procedures reported in the literature.<sup>55,56</sup> In the present peak-fitting, we used two components D'' and D''' between the D and G bands to achieve a best-fit of the Raman spectrum. Figure 7C shows an example of the Raman best fit corresponding to the GO spectrum while the trend of the peak intensities as a function of the HI concentration is depicted in Figure 8. To compare the



Figure 7. (A) Raman spectra of GO and rGO reduced with different HI concentrations. (B) Zoomed view of the D and G band evolution as a function of the HI concentration, (C) example of the Raman band fitting together with the fit component assignment.

bands deriving from the various Raman spectral fitting, all the intensity values were normalized for the total intensity of the parent Raman spectrum (i.e.,  $I(x) = I_0(x)/I_{tot}$ , where  $I_0(x)$  is the original spectral intensity of the fit component *x*, while  $I_{tot}$  is the total spectral intensity of the seven components).

The interpretation of the main Raman components is well described in the literature. The D\* component at  $\sim$ 1200 cm<sup>-1</sup> was related to the formation of a disordered graphitic lattice by

 $sp^2-sp^3$  bonds.<sup>57</sup> As reported in Figure 8, this component decreases with increasing reduction of the GO testifying the reconstruction of an ordered graphitic layer by removing the  $sp^3$ -induced oxygen bonds. The trend of the D\* band is in excellent agreement with the trend of the oxygen.

The D band in our spectra is centered at 1333 cm<sup>-1</sup>. The D band is associated with an  $A_{1g}$  breathing mode at the Brillouin zone symmetry point K. The intensity of this structure is correlated with the number of defects in the graphene plane.<sup>58</sup> It increases with increasing reduction process reaching a plateau at the higher HI concentrations. Likely, the removal of the oxygen bonds leads to the formation of defects, which are not fully compensated by the reconstruction of the graphitic layer (as it appears from Figure 7, the spectral power of the D band is much more intense with respect to that of the G band).

The components 3 and 4 are assigned to D'' and D''' at ~1450 and 1535 cm<sup>-1</sup>, respectively. These fit components have been correlated with the presence of oxygen<sup>56</sup> and the degree of crystallinity.<sup>57,59</sup> The trend of the sum (D'' + D''') is in agreement with that of  $D^*$  and with the XPS results. In addition, the decreasing intensity of these components is attributed to the decreasing FWHM of the D and G bands.

The component 5 is assigned to the G band describing the first-order  $E_{2g}$  optical mode of the carbon–carbon double bond of the graphite plane.<sup>60,61</sup> As shown in Figure 8, the spectral intensity of this band increases as the HI molar concentration increases. As expected, the reduction process increases the spectral power of the component describing the C=C graphitic component. The position of the G band is sensitive to the presence of oxidized carbon atoms. In agreement with the literature,<sup>62</sup> the position of the G band shifts to higher frequencies in the presence of a high degree of graphene oxidation as it occurs in GO. Upon reduction, the position of the G band shifts back to lower frequencies as summarized in Table 2.

The component 6 represents the D' band at ~1610 cm<sup>-1</sup>, which is assigned to the intravalley double resonance process and appears in the Raman spectra of the defected materials.<sup>63</sup> As occurs for the D band, the intensity of D' is associated with the degree of disorder which increases with the reduction process. Finally, at ~1710 cm<sup>-1</sup>, a weak oscillation peak assigned to the M band is found. This feature is attributed to an intravalley resonant scattering process originating from the combination of the out-of-plane layer-breathing mode and the in-plane longitudinal optical mode.<sup>64,65</sup> The fit component is very weak and it disappears in the Raman spectra of the samples treated with the higher HI concentrations.

In Figure 8, the trend of the I(D)/I(G) ratio is reported. In the first stage of the reduction process, because of the creation of defects, vacancies, and change of bond hybridization the disorder is prevalent with respect to the production of reduced carbon atoms. In the second stage, the ratio reaches a plateau. Also, this trend is in agreement with the reduction of the oxygen concentration displayed in Figure 5, which flattens at the higher HI concentrations and also with the trend of the D\* and D bands.

To further characterize the GO and of the rGO samples, XRD was performed. The results are summarized in Figure 9. As it clearly appears, the GO sample reproduces the canonical XRD spectrum of GO in agreement with recent literature.<sup>66,67</sup> The peak at around  $2\theta = 10^{\circ}$  corresponds to an interlayer spacing of about 0.8 nm. In graphite, the (002) diffraction peak occurs at around  $2\theta = 26.4^{\circ}$  corresponding to a lattice spacing



Figure 8. Trend of (A) D band; (B) G band, (C) D' band; (D) D'' + D''' bands; (E) M band, and finally (F) I(D)/I(G) ratio as a function of the HI concentration used in the GO reduction process.

of 3.34 nm. The increase of the interlayer spacing is because of the intercalation of the oxygen-containing functional groups as reported in the literature.<sup>68,69</sup> With increasing degree of

reduction, this peak disappears. On the contrary, some features appear around  $2\theta = 24.5^{\circ}$  corresponding to a *d*-spacing of about 0.36 nm. The reduction of the interlayer distance from

Table 2. Position and FWHM of the G Band as a Function of the Hi Concentration

	HI conc. (M)	G position $(cm^{-1})$	I(D)/I(G)	FWHM $(cm^{-1})$
GO	0	1594	3.18	20.5
rGO	0.06 M	1590.6	3.35	20.6
rGO	0.12 M	1590.3	3.56	19.4
rGO	0.24 M	1589.7	3.73	18.1
rGO	0.47 M	1588.5	3.68	17.8
rGO	0.95 M	1586.6	3.61	16.0



Figure 9. XRD patterns of GO and rGO reduced with different HI concentrations.

GO to rGO testifies the removal of the oxygen functional groups in agreement with the Raman and XPS results. The reduction process then leads to a partial reconstruction of graphitic domains. However, the feature is rather broad mirroring the small dimensions of these domains. The increased graphitization of the GO patches appears clearly in Figure 10. Initially, the high polarity of the GO particulate



Figure 10. Suspension stability of GO and rGO reduced with different HI concentrations.

renders the GO sheets easily dispersible in water. This property is progressively lost by removing the oxygen from the GO layers. This causes a gradual instability of the rGO dispersion with increasing aggregation caused by van der Waals and  $\pi-\pi$  stacking forces. After 24 h from the reduction, the GO suspension is stable while the rGO forms clusters and, at a higher degree of reduction, forms a hydrogel.

The conductivity in the graphene sheets depends on the transport properties of the electron charge.<sup>70</sup> This phenomenon, in turn, is affected by structural defects, functionality, and layer disorder. Despite the presence of oxygen limiting the electron mobility, rGO displays a conductive character.

Different factors have been proposed to explain the rGO conductivity:<sup>32</sup> (i) percolation mechanisms across particle interfaces; (ii) conduction through the conductive network; and (iii) conduction due to ionic channels, which can explain the dependence of rGO conductivity on temperature and humidity. Because of the high polarity of the GO surface, the last mechanism is on the basis of its conductivity. The dependence of the conductivity by defects and the presence of oxygen allowed us to further characterize the extent of reduction at increasing levels of HI. The bulk resistance of the free-standing GO and rGO films measured using a multimeter is plotted in Figure 11. With the increase of the



**Figure 11.** Bulk resistance of the free-standing film prepared with GO and rGO reduced with different HI concentrations. Error bars are also indicated for each of the measurements.

HI concentration used for GO reduction, the bulk resistance of the rGO film decreased quickly. The resistance of GO is 14.8  $\pm$  1.8 M $\Omega$ , while that of rGO-0.95 M is 92  $\pm$  1  $\Omega$ . This result illustrates that it is possible to control the electrical properties of rGO to suit different applications, for example, flexible electronic circuits for electronic devices or low coat insulating layers for silicon solar cells.

#### 3. CONCLUSIONS

In this work, hydroiodic acid was utilized as the reduction agent to remove oxygen from GO sheets. GO chemical processing was carried out with increasing concentrations of HI to understand the extent of the reduction. The characterization techniques show that initially the reduction process proceeds efficiently. Then, when the residual oxygen abundance lowers, removing oxygen atoms becomes more difficult. Also, increasing the HI concentration, the reduction efficiency strongly decreases and an oxygen concentration of about 10% is obtained. In agreement with this evidence, the TGA displays a decreasing amount of weight in the reduced GO samples while, in the UV–vis spectra, a red-shift of the absorption peak is observed. Moreover, the Raman spectra show an increasing graphitization of the material which agrees with the XRD analyses. We demonstrated that HI is an efficient reducing agent enabling a fine control over the degree of reduction by simply varying its concentration and the residual oxygen concentration. This was confirmed by bulk resistance measurements, which indicated that the bulk resistance of the rGO film can be adjusted in the range of 14.8 M $\Omega$  to 92  $\Omega$ .

Reduction of the resistivity opens important perspectives for the use of rGO as a transparent electrode for photovoltaics.<sup>71</sup> Then, upon decreasing the oxygen content, the material's properties can be reshaped. Upon reduction, the bandgap of pristine GO ~2.2 eV, may be decreased leading to semiconducting material properties facilitating its applications in electronics,<sup>72,73</sup> also the possibility of rGO doping can also be considered<sup>74,75</sup> for sensing<sup>75</sup> optics applications.<sup>76</sup> In addition, reduction of the oxygen concentration to the desired concentration not only eliminates the oxidative stress induced by GO on living cells but promotes the cell growth,<sup>77</sup> while maintaining the possibility to functionalize the material.<sup>78</sup> This indicates that the capability to thinly control the reduction of GO is important in all the various applications where the oxygen content play an important role.

## 4. EXPERIMENTAL SECTION

**4.1. Chemicals.** GO water suspension of 4 mg mL<sup>-1</sup> was purchased from Graphenea. Its monolayer content exceeds 95% at a concentration of 0.5 mg mL<sup>-1</sup>. HI acid (57 wt %, 99.999%) and absolute ethanol (99.5%) were purchased from Aldrich and Merck, respectively. Milli-Q water was used for the experiments.

4.2. Reduction of Graphene Oxide. The reduction of GO using HI as the reductant was performed in an aqueous solution. In a typical synthesis, 10 mL 4 mg mL<sup>-1</sup> GO solution was diluted into 0.8 mg mL<sup>-1</sup> using Milli-Q water under ultrasonication for 5 min in a 250 mL round bottom flask. Then, 50 mL HI aqueous solution at different molar concentrations X (X = 0.06, 0.12, 0.24, 0.47, and 0.95 M) was added into the GO solution and mixed thoroughly under ultrasonication for another 5 min. The flask containing above mixture was heated to 90 °C in an oil bath and kept at this temperature to carry out the reduction reaction under vigorous stirring. After 4 h reaction, the resulting mixture was cooled down using an ice bath and the rGO product was collected by vacuum filtration using a cellulose filtration paper. After washing with Milli-Q water and absolute ethanol alternatively several times, the rGO powder was dried under vacuum overnight. Samples were denoted as rGO-X (X is the molar concentration of HI for GO reduction).

**4.3. Preparation of GO and rGO Films.** GO and rGO films were prepared using the reported vacuum filtration method with some modifications.<sup>35</sup> In order to disperse both GO and rGO, water-ethanol solution of 10 mL with a volume ratio of 1:1 was used to disperse 4 mg each sample under ultrasonication. Then solution was filtered through a polycarbonate membrane (nucleopore track-etch membrane, Whatman) with a diameter of 25 mm and a pore channel size of 0.8  $\mu$ m. The polycarbonate membrane was used as received. The GO/rGO dispersions in water/ethanol solution were slowly filtered through the membrane under vacuum. Continuous films were obtained for both GO and rGO thanks to the hydrophilic groups of the filtration membrane, which prevent cracking of film into flakes. The obtained membrane has a diameter of 17.2 mm and a thickness of 19 ± 2  $\mu$ m. The

GO and rGO films were then dried for carrying out further test.

**4.4. Characterization and Tests.** X-ray diffraction (XRD) patterns of GO and rGO were measured on an APD 2000 powder diffractometer from GNR-Analytical Instruments Group with monochromated Cu K $\alpha$  radiation ( $\lambda = 1.541$  Å) operated at 40 kV and 30 mA. The scan range of the diffraction angle was set to a range of 5 to 40° with a step size of 0.02° and 5 s per step. Interlayer spacing of GO and rGO was calculated using Bragg's law:  $\lambda = 2d \sin(\theta)$ , where  $\lambda$  is X-ray wavelength, d is the interlayer spacing of GO or rGO, and  $\theta$  is the diffraction angle.

TGA–DSC analysis was simultaneously carried out on a Mettler Toledo TGA–DSC 2 system controlled using a STARe software program. The powder sample in an alumina crucible was heated from room temperature to 800 °C at a ramp of 10 °C min<sup>-1</sup> under a flow of argon gas. Changes in sample mass and heat flow along with temperature increase were monitored using STARe software.

X-ray photoelectron spectra (XPS) were recorded using a Kratos Axis Ultra DLD spectrometer equipped with a 150 W monochromated Al K $\alpha$  excitation source (1486.6 eV). GO and rGO samples were attached on the XPS sample holder using a conductive double-side adhesive tape. Prior to the measurement, samples were degassed under high vacuum overnight. A pass energy of 160 and 20 eV was used for obtaining wide survey spectra and high-resolution core-line spectra, respectively. The obtained spectra were analyzed using home-made RxpsG software based on R platform.<sup>79</sup>

Optical absorbance measurements of GO and rGO were performed on a JASCO V-670 Ultraviolet-visible-near infrared (UV-vis-NIR) spectrometer. 0.05 mg mL<sup>-1</sup> of GO or rGO solution for the measurement was prepared by dispersing the powder sample in ethanol under ultrasonication. The spectra were scanned from 800 to 200 nm using a quartz cuvette with an optical path of 10 mm.

Raman spectra were collected on a Labram Aramis microRaman system from HORIBA Jobin Yvon. An excitation wavelength of 632.8 nm from the He–Ne source was used and the spectra were scanned from 300 to 3000 cm<sup>-1</sup>. Raman samples were prepared by pressing GO or rGO powder on a microscope slide. The Raman spectra were fitted using linear background subtraction and Voigt functions.

Electrical resistance of the prepared free-standing GO and rGO films was measured using an Avidsen 107100 multimeter under ambient conditions. During the measurement, the two probes of the multimeter were put on the edges of the film along the diameter line of the film. For each film, three values were obtained at different points to get an average value.w.liu@unsw.edu.au

## ASSOCIATED CONTENT

#### Supporting Information

The Supporting Information is available free of charge at https://pubs.acs.org/doi/10.1021/acsomega.0c05578.

XPS O 1s and C 1s spectra of the pristine GO and of graphene reduced with the increasing HI concentrations and examples of O 1s and C 1s peak-fitting (PDF)

## AUTHOR INFORMATION

#### **Corresponding Author**

Giorgio Speranza – Fondazione Bruno Kessler, Trento 38123, Italy; Department of Industrial Engineering, University of Trento, Trento 38123, Italy; Istituto di Fotonica e Nanotecnologie, IFN-CNR, Trento 38123, Italy; orcid.org/0000-0003-1478-0995; Email: speranza@ fbk.eu

#### Author

Wei Liu – Fondazione Bruno Kessler, Trento 38123, Italy

Complete contact information is available at:

https://pubs.acs.org/10.1021/acsomega.0c05578

# Notes

The authors declare no competing financial interest.

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